



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No.10/609,311
Filing Date June 26, 2003
Inventor..... Donald L. Yates
AssigneeMicron Technology, Inc.
Group Art Unit.....1756
Examiner Kathleen Duda
Attorney's Docket No.MI22-2236
Customer No.021567
Title Semiconductor Processing Patterning Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Reference - - See attached Form PTO-1449

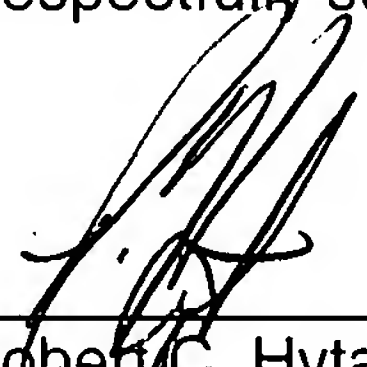
The attached Form PTO-1449 is submitted in compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98. Pursuant to Federal Register Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. No admission is made regarding whether the submitted reference is prior art.

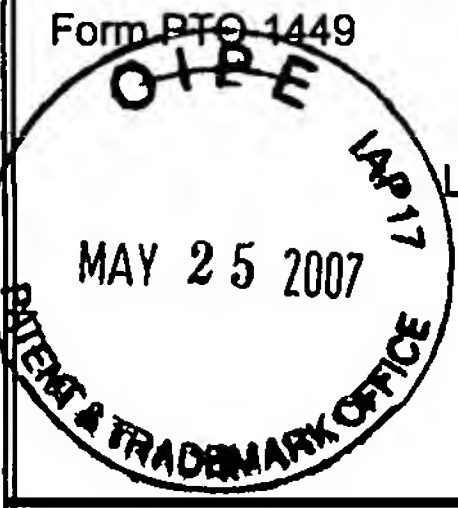
This Supplemental Information Disclosure Statement is being filed with a Response to Final Office Action to Accompany Request for Continued Examination (RCE). Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925

Citation of these references is respectfully requested.

Respectfully submitted,

Date: 5/22/07


Robert C. Hyta
Reg. No. 46,791

Form PTO 1449 		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2236		SERIAL NO. 10/609,311	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Donald L. Yates			
U.S. PATENT DOCUMENTS				FILING DATE June 26, 2003		GROUP 1756	
*Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
AA	6,169,019	01/01	Takagi				
AB	6,943,126	09/05	Narayanan et al.				
AC	2004/0219736	11/04	Yoshitaka				
AD	2005/0035460	02/05	Tseng				
AE	2005/0266619	12/05	Brask et al.				
AF	2005/026664	12/05	Harrison et al.				
AG	2006/0064969	05/02	Havemann				
AH	2006/0183277	08/06	Brask et al.				
AJ							
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
AJ							
AK							
AL							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AM						
	AN						
	AO						
EXAMINER		DATE CONSIDERED					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							